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Bib Data Sheet

CONFIRMATION NO. 2890

SERIAL NUMBER 09/805,811	FILING DATE 03/13/2001 RULE	CLASS 324	GROUP ART UNIT 2862	ATTORNEY DOCKET NO. A-392	
<b>APPLICANTS</b> Saburo Uehara, Tokyo, JAPAN;					
<b>** CONTINUING DATA *****</b>					
<b>** FOREIGN APPLICATIONS *****</b> JAPAN 2000-113071 04/14/2000					
<b>IF REQUIRED, FOREIGN FILING LICENSE GRANTED</b> <b>** 04/23/2001</b>					
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met Verified and Acknowledged <i>Manjitharan Bana</i> MCB Examiner's Signature Initials		STATE OR COUNTRY JAPAN	SHEETS DRAWING 5	TOTAL CLAIMS 5	INDEPENDENT CLAIMS 2
<b>ADDRESS</b> 802					
<b>TITLE</b> Semiconductor device testing apparatus and test method therefor					
<b>FILING FEE RECEIVED</b> 840	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT. No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue ) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit		